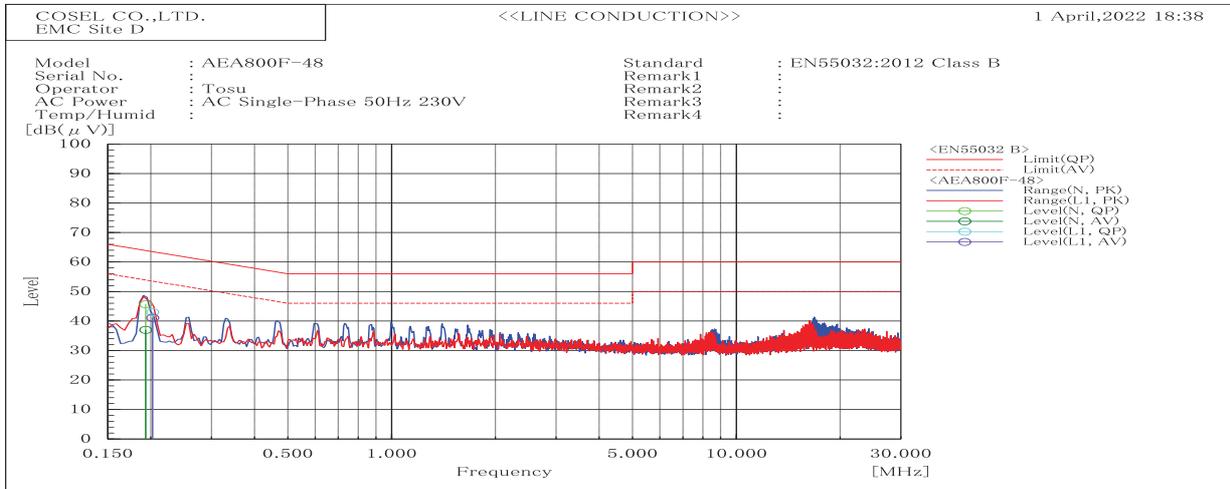
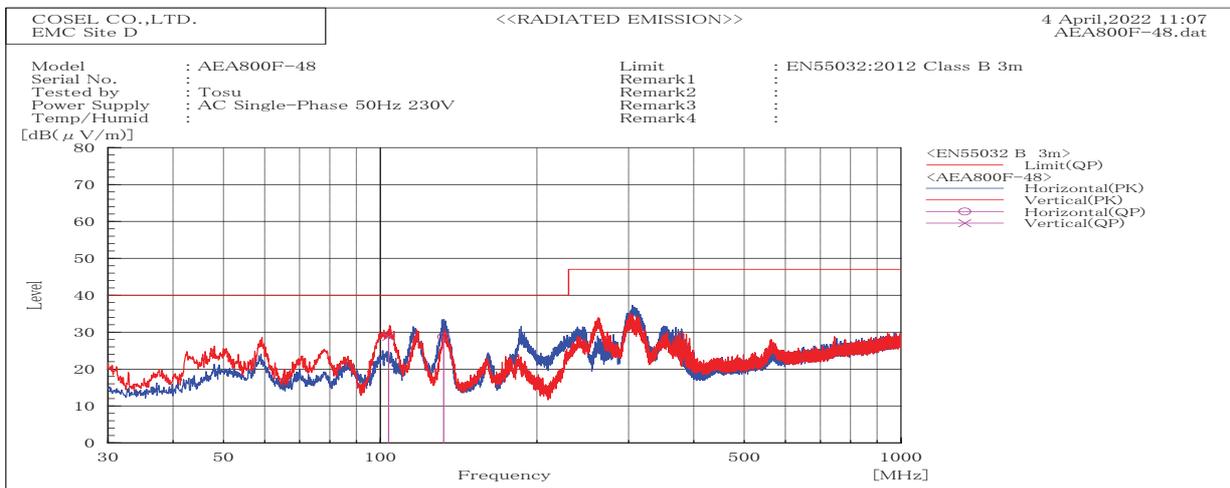


DATA SHEET		Date	05-Sep-22
Model	AEA800F-48	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	M.Tosu



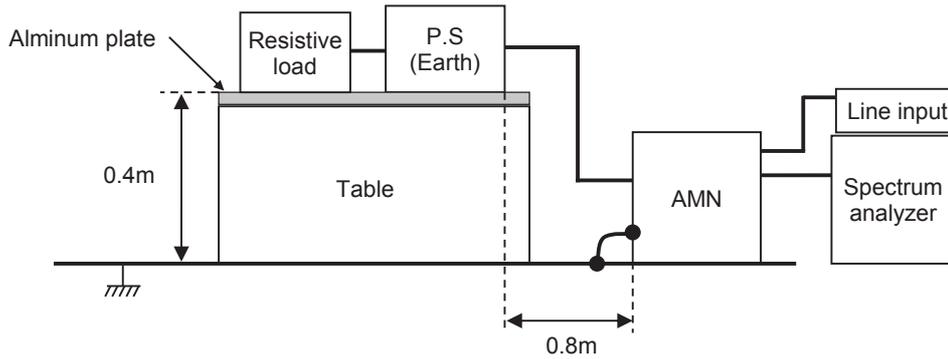
Frequency MHz	Line	Level dB(μV)		Limit dB(μV)		Margin dB		Pass/Fail	Remark
		QP	AV	QP	AV	QP	AV		
0.203	L1	43	41.1	63.5	53.5	20.5	12.4	Pass	
0.193	N	45.7	37	63.9	53.9	18.2	16.9	Pass	



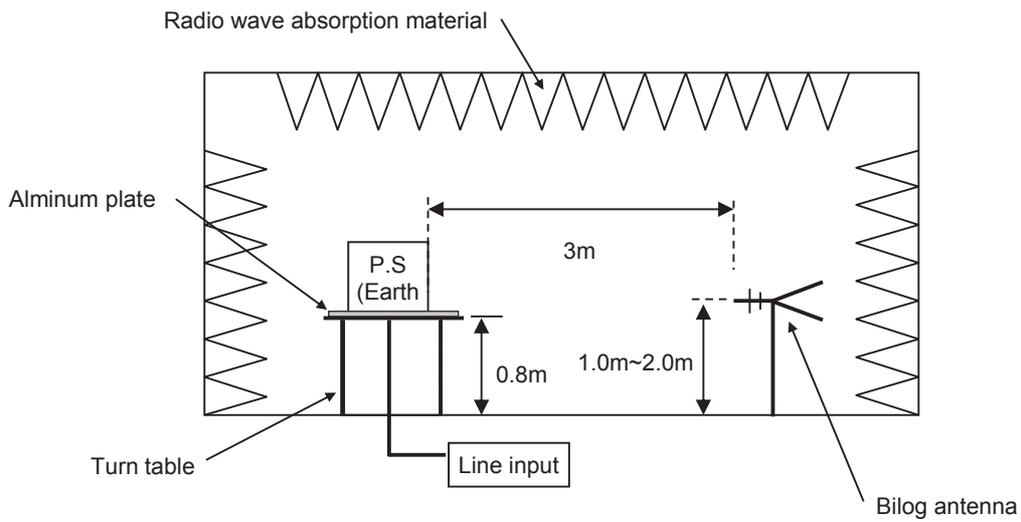
Frequency MHz	Polarization	Stability	Level dB(uV/m)		Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	QP					
103.735	V	Stable	28.8	40	11.2	Pass	105.7	116	
132.343	H	Stable	28.7	40	11.3	Pass	199.7	0	

DATA SHEET		Date	05-Sep-22
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	M.Tosu

**1. Line conduction**



**2. Radiated emission**



**Conditions**

Test : EMI  
Model Name: AEA800F-48

**Photographs of Test Set-Up****1.LINE CONDUCTION****2.RADIATED EMISSION**